

Notice of References Cited

Application/Control No.

10/573,248

Applicant(s)/Patent Under
Reexamination
HIRAI ET AL.

Examiner

CLAYTON WILLIAMS

Art Unit

4152

Page 1 of 1

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-----------------|----------------|
| * | A | US-2005/0050026 | 03-2005 | Kawamura et al. | 707/003 |
| * | B | US-6,681,252 | 01-2004 | Schuster et al. | 709/227 |
| * | C | US-2002/0112058 | 08-2002 | Weisman et al. | 709/227 |
| * | D | US-2004/0260800 | 12-2004 | Gu et al. | 709/223 |
| * | E | US-7,213,070 | 05-2007 | Chalon, Denis | 709/226 |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) | | | |
|---|---|---|--|--|--|
| | U | | | | |
| | V | | | | |
| | W | | | | |
| | X | | | | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.